

Abstract Submitted
for the MAR07 Meeting of
The American Physical Society

Ferroelectric Phase transition in $(1-x)\text{Pb}(\text{Fe}_{2/3}\text{W}_{1/3})\text{O}_3\text{-xPbTiO}_3$ solid solutions thin films ASHOK KUMAR, University of Puerto Rico, N.M. MURARAI, RAM S. KATIYAR, University of Puerto Rico — We have deposited thin films of $(1-x)\text{Pb}(\text{Fe}_{2/3}\text{W}_{1/3})\text{O}_3\text{-xPbTiO}_3$ (PFWT) on Pt/Si substrates. The metamorphic phase diagram of PFWT solid solution indicates that it changes from natural relaxor to an ordered ferroelectric state above $x = 0.33$ of lead titanate concentration. The microstructure and surface morphology were investigated using SEM and AFM techniques that indicated surface roughness of 10-15 nm with particle size of $\sim 30\text{-}50$ nm. The dielectric relaxation studies in these films were carried out measured in the temperature range of 100K-650K and the frequency range of 100Hz-1MHz. The ferroelectric phase transition was found at 575K for all frequencies. The Relaxation indication coefficient ($\gamma \sim 1.30$) was estimated from a linear fit of the modified Curie-Weiss law and results suggested a long range ordering. The temperature dependant micro Raman studies revealed a ferroelectric phase transition from tetragonal to cubic phase above 575K. The polarization hysteresis curve at room temperature illustrated a ferroelectric nature of the material having raman polarization (P_r) to be $3\mu\text{C}/\text{cm}^2$ and the saturation polarization (P_s) $30\mu\text{C}/\text{cm}^2$.

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Date submitted: 06 Dec 2006

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